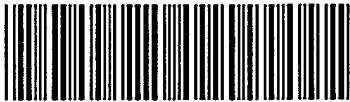


Search Notes

Application No.

09/739,582

Examiner

Chris C. Chu

Applicant(s)

TEIG ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
716	2, 5, 7, 8, 11, 12, 14 & 15	2/3/2004	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; and IBM_TDB	2/3/2004	C.C.